IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Takuji MAEDA et al. Application No.: 10/553,725

Art Unit: 2876 Examiner: Hess, D.

Title: SEMICONDUCTOR MEMORY CARD, SEMICONDUCTOR MEMORY CONTROL APPARATUS, AND SEMICONDUCTOR MEMORY CONTROL METHOD

International Application No.: PCT/JP2004/013703 International Filing Date : September 13, 2004 Priority Date : September 18, 2003

U.S. Filing Date

: October 19, 2005

Mail Stop Amendment

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

TRANSMITTAL LETTER

Sir:

In response to the Office Action dated March 11, 2009, applicants hereby submit the enclosed papers including an Amendment under 37 CFR 1.111.

The required fees are calculated below:

Total Claims \$0.00 Independent \$0.00

TOTAL FEE DUE:

\$0.00

THE COMMISSIONER IS AUTHORIZED TO CHARGE THIS FEE AND ANY OTHER FEES WHICH MAY BE REQUIRED OR CREDIT ANY OVERPAYMENT TO DEPOSIT ACCOUNT NO. 19-2586, REFERENCING ATTORNEY DOCKET NO. 0074/057001. THIS IS A GENERAL AUTHORIZATION EXCLUDING ONLY PAYMENT OF THE ISSUE FEE.

Respectfully submitted,

Date: June 5, 2009

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PATENT ATTORNEY DOCKET NO. 0074/057001

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AMENDMENT UNDER 37 CFR 1.111

Sir:

In response to the Office Action dated March 11, 2009, please amend the application as follows:

Amendments to the Claims begin on page 2 of this paper.

Remarks begin on page 6 of this paper.